

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10582271	MARSACQ ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Kwang Han	1795	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
429	27,46,206,213	11/7/2007	AC
526	72,293	11/7/2007	AC

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor search on eDAN	11/6/2007	AC
PLUS search	11/7/2007	AC
STN search performed by STIC (results attached)	11/23/2007	AC
EAST: Searched class 429 with various text (US-PPGUB, USPAT, EPO, JPO, DERWENT) - see search history	1/28/2009	AC
eDAN: Updated inventor search	2/17/2009	AC
See updated EAST search notes	9/22/2009	KH
See updated EAST search notes	12/30/2009	KH

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
429	12,13,33,40,42	5/6/2010	KH